

Issue Classification



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Applicant(s)/Patent under Reexamination

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Examiner

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Art Unit

2629

ORIGINAL

CLASS

SUBCLASS

345

98

CLAIMED

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NON-CLAIMED

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

345

87

89

95

100

204

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8/30/06

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Total Claims Allowed:

17

O.G.
Print Claims)

1

O.G.
Print Figure

3